

| | | | |
|--|---------------------------------------|---|-------------|
| <i>Notice of References Cited</i> | Application/Control No. 10/781,819 | Applicant(s)/Patent Under Reexamination UEDA ET AL. | |
| | Examiner Tan V. Mai | Art Unit 2193 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-----------------------|----------------|
| * | A | US-2005/0125471 | 06-2005 | Sturm et al. | 708/250 |
| * | B | US-4,176,399 | 11-1979 | Hoffmann et al. | 708/250 |
| * | C | US-7,188,131 | 03-2007 | Bardouillet, Michel | 708/251 |
| * | D | US-6,857,003 | 02-2005 | Saito, Yoshiaki | 708/801 |
| * | E | US-7,007,060 | 02-2006 | Miller, Jr., Robert H | 708/801 |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.